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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Complete if Known				
Application Number 10/690,470				
Filing Date	October 20, 2003	-		
First Named Inventor	Warburton, William K.			
Art Unit	2857			
Examiner Name	Unassigned			
Attorney Docket Number	017032-000511US			

•	U.S. PATENT DOCUMENTS+					
	Examiner Cite Initials No.		Document Number Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Signature	Mil 2 hre	Date Considered	5/2/05

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.

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October 20, 2003

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STATEMENT B	Y APPLICANT

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TEMENT BY APPLICANT
First Named Inventor Warburton, William K.

Art Unit 2857
(use as many sheets as necessary)
Examiner Name Unassigned

Filing Date

Application Number

Attorney Docket Number

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	т
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